PHOSPHOR THERMOMETRY TECHNIQUES FOR THE REALIZATION OF THERMAL STANDARDS

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Acknowledgments to several colleagues at:

ORNL, Engineering Technology Division Los Alamos National Laboratory, USAF, DOE University of Tennessee, Department of Physics U.Va., Department of Mechanical and Aerospace Engineering The International Bureau of Weights and Measures The U.S. National Institute of Standards and Technology

THE DEGREE KELVIN

A BASE UNIT OF THE SI

Le Système international d'unités The International System of Units

international des poids et mesures

Bureau

TETPO T

2.1.1.5 Unit of thermodynamic temperature (kelvin)

The definition of the unit of thermodynamic temperature was given in substance by the 10th CGPM (1954, Resolution 3; CR, 79) which selected the triple point of water as the fundamental fixed point and assigned to it the temperature 273.16 K so defining the unit. The 13th CGPM (1967-1968, Resolution 3; CR, 104 and *Metrologia*, 1968, **4**, 43) adopted the name *kelvin* (symbol K) instead of "degree Kelvin" (symbol °K) and defined the unit of thermodynamic temperature as follows (Resolution 4; CR, 104 and *Metrologia*, 1968, **4**, 43):

The kelvin, unit of thermodynamic temperature, is the fraction 1/273.16 of the thermodynamic temperature of the triple point of water.

Because of the way temperature scales used to be defined, it remains common practice to express a thermodynamic temperature, symbol T, in terms of its difference from the reference temperature $T_0 = 273.15$ K, the ice point. This temperature difference is called the Celsius temperature, symbol t, and is defined by the quantity equation

 $t = T - T_0.$

The unit of Celsius temperature is the degree Celsius, symbol °C, which is by definition equal in magnitude to the kelvin. A difference or interval of temperature may be expressed in kelvins or in degrees Celsius (13th CGPM, 1967-1968, Resolution 3, mentioned above). The numerical value of a Celsius temperature *t* expressed in degrees Celsius is given by

 $t/^{\circ}C = T/K - 273.15.$

The kelvin and the degree Celsius are also the units of the International Temperature Scale of 1990 (ITS-90) adopted by the CIPM in 1989 in its Recommendation 5 (CI-1989) (PV, **57**, 115 and *Metrologia*, 1990, **27**, 13).

7º édition 1998

Organisation intergouvernemental

REALIZATION OF THE DEGREE KELVIN

Direct measurements of thermodynamic temperature: require "primary thermometers":

Constant-volume gas thermometer Acoustic gas thermometer Spectral and total radiation thermometers Electronic noise thermometer

Uncertainties: \leq 5 mK up to 373 K

Secondary thermometers: Platinum resistance thermometer

Easier to use Reproducability ≈10 times better

THE INTERNATIONAL TEMPERATURE SCALE OF 1990: (ITS-90)

"A temperature scale that is consistent with all the known laws of thermodynamics is termed a thermodynamic temperature scale. In practice, a well-understood thermodynamic system, such as an ideal gas, is prepared in the laboratory such that its thermodynamic temperature can be predicted from other known properties. Laboratory thermometers can then be calibrated at this thermodynamic temperature. The International Temperature Scale of 1990 is an approximation to the thermodynamic temperature scale."

Source: http://www.cstl.nist.gov/div836/836.05/thermometry/tempresearch/temperaturescale.htm

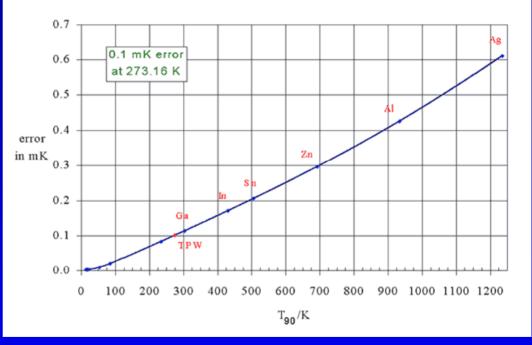
FEATURES AND USE OF THE ITS-90

Reference Points

Error Curve

Material	T ₉₀ /K	t ₉₀ /°C
e-H ₂ (TP)	13.8033	-259.3467
e-H ₂ (VP)	17	-256.15
e-H ₂ (VP)	20.3	-252.85
Ne (TP)	24.5561	-248.5939
O ₂ (TP)	54.3584	-218.7916
Ar (TP)	83.8058	-189.3442
Hg (TP)	234.3156	-38.8344
H ₂ O (TP)	273.16	0.01
Ga (MP)	302.9146	29.7646
In (FP)	429.7485	156.5985
Sn (FP)	505.078	231.928
Zn (FP)	692.677	419.527
Al (FP)	933.473	660.323
Ag (FP)	1234.93	961.78
e: triple point	L	L
P: melting point		
: freezing point		

ITS-90 Calibration Error Propagation TPW (13.8033 K to 1234.93 K)



Source: <u>http://www.cstl.nist.gov/div836/836.05/thermometry/</u> miscelaneous/faq.htm

The ITS-90 is:

- One of the most significant accomplishments in all of metrology
- Involves scientific input from all major national metrological laboratories around the world
 - Constantly being improved and reviewed by the CCT, CIPM and the CGPM

The ITS-90 is also:

- A discontinuous collection of thermodynamic fixed points (artefactual, not atomic standards)
- It therefore requires very broad interpolation over its entire range
 - Unable to be realized by end users in industrial and other laboratories

FLUORESCENCE THERMOMETRY HAS THE POTENTIAL TO:

- Generate a continuous, uninterpolated scale from the cryogenic to the high temperature regimes
 Be founded on scientific "first principles" (quantum mechanics and statistical physics)
 Let the observables be atomic phenomena and processes (eg., quantized decay states)
 Tie all measurements to frequency and time standards
 - Use doped single crystals of high stability ceramic oxides as the luminescent materials

LASER-INDUCED FLUORESCENCE OF THERMOGRAPHIC PHOSPHORS



Vol. 68, No. 7, July 1997

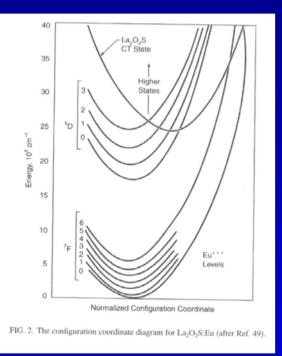
Remote thermometry with thermographic phosphors: Instrumentation and applications

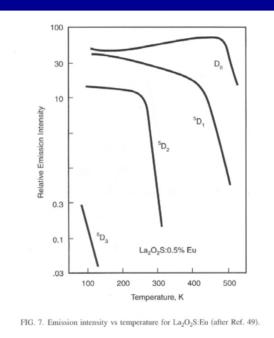
S. W. Allison Engineering Technology Division, Oak Ridge National Laboratory, Oak Ridge, Tennessee 37831-7280 (G, T, Gillies Department of Mechanical, Aerospace, and Nuclear Engineering, University of Virginia, Charlottesville, Virginia 22901 pp. 2615-2650

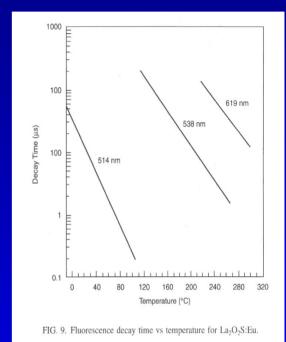
- 50 years of research into the techniques
- Well understood quantum mechanical basis
 - Measurement solutions for industrial, military problems
- Instrumentation systems are common to optical metrology



PHYSICAL BASIS FOR THE TECHNIQUE







Charge transfer states in rare-earth doped ceramic oxides and oxysulfides

Emission intensities vary with temperature of the host material Decay lifetimes of excited states vary with temperature of host material

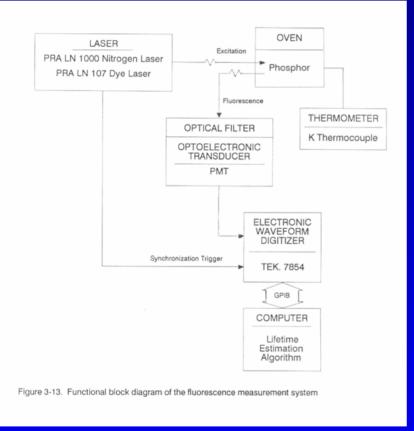
Decay-time constant is the key quantity

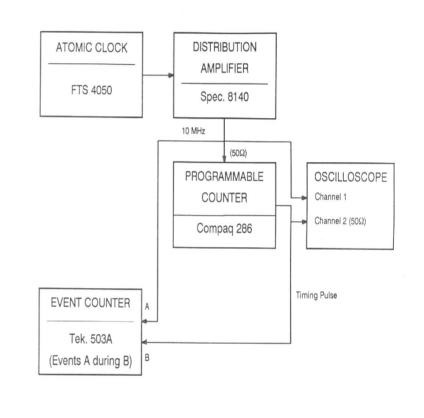
• Fonger and Struck model (1970)

 $\tau = [(1/\tau_0) + b \cdot e^{-(E/kT)}]^{-1}$

- Ideally, τ_0 , b, E are determined by atomic theory
- \cdot τ is measured relative to atomic clock time-base
- \cdot τ varies smoothly with temperature

EXPERIMENTAL ARRANGEMENT FOR REALIZING THE "FTS-89" AND THE DEGREE KELVIN

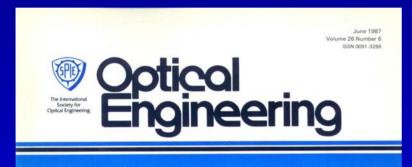


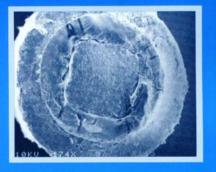


Source: L. J. Dowell, Ph.D. Dissertation, U.Va., 1989

CHARACTERIZING THE INSTRUMENTATION

· OPTICAL SYSTEM ALIGNMENT





In this issue:

Interferometric Pattern Analysis Linear Array Detectors Infrared Imaging Holographic Optical Elements Magnetic Recording Heads Remote Sensors Phase-Only Hitter Optical Recording Media Image Resolution Hiber Optic Sensors Fiber Optic Systems Synthetic Aperture Systems Flatness Measurement

SPIE Reports — Book Reviews Short Courses — Meetings Dowell, L. J., Gillies, G. T., and Allison, S. W., "Measurements of Lateral Offset Power Losses in Optical Fibers Scanning Point Sources," <u>Optical Engineering</u>, Vol. 26 (1987), pp. 547-552

SAMPLE-POSITIONING REQUIREMENTS DUE TO THERMAL GRADIENTS IN OVEN

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1.7.2.R	Furnace	Profile a	at 1000 C	1014.EX

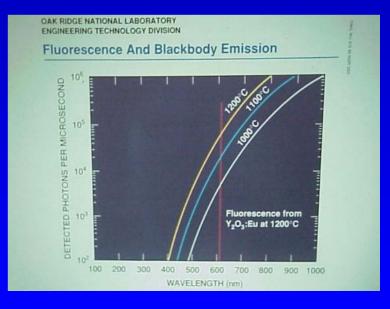
Lutz, W. N., Gillies, G. T., and Allison, S. W., "Computer-Aided Dated Acquisition System for Thermal Gradient Mapping and Calibrations of High-Temperature Cavities," <u>Review of Scientific Instruments</u>, Vol. 60 (1989), pp. 673-682.

· BLACKBODY BACKGROUND IN FURNACE

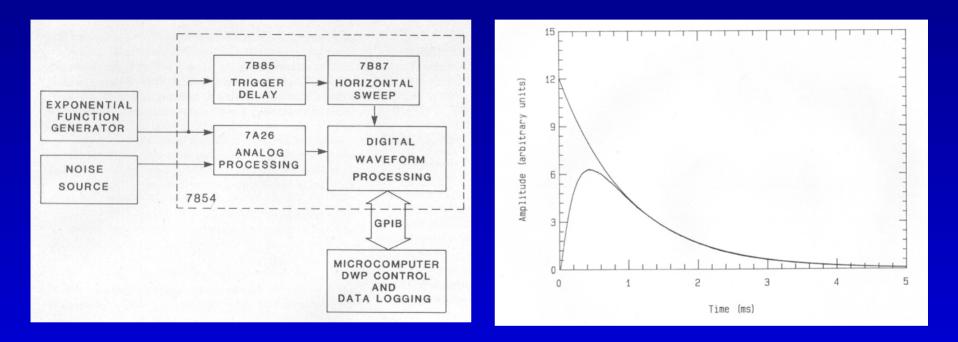


Almost an order of magnitude increase in the number of photons detected per 100 degree increase in temperature at 619 nm.

Careful optical bandwidth selection via filtering is needed to discriminate against the wideband background.



ACCURACY OF WAVEFORM DIGITIZER



Dowell, L. J., Gillies, G. T., Cates, M. R., and Allison, S. W., "Precision Limits of Waveform Recovery and Analysis in a Signal Processing Oscilloscope," <u>Review of Scientific Instruments</u>, Vol. 58 (1987), pp. 1245-1250.

ACCURACY OF TIME CONSTANT ANALYSIS

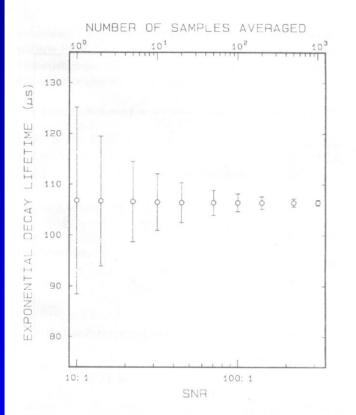


FIG. 3. Simulation results for the two data point estimation as a function of signal-to-noise ratio. Noise in a signal is reduced by averaging the signal measurements, and the SNR improves as the square root of the number of signal samples averaged. Here, the results simulate averaging a signal with an initial SNR of 10:1.

Dowell, L. J. and Gillies, G. T., "Precision Limits of Lifetime Estimation Algorithms as Determined by Monte Carlo Simulation: A Comparison of Theory and Experiment," <u>Review of Scientific Instruments</u>, Vol. 59 (1988), pp. 1310-1315.

Dowell, L. J. and Gillies, G. T., "Errors Caused by Baseline Offset and Noise in the Estimation of Exponential Lifetimes," <u>Review of Scientific Instruments</u>, Vol. 62 (1991), pp. 242-243.

• Y₂O₃:Eu SINGLE CRYSTAL PURITY

Impurity Element	YCl ₃	Eu ₂ O ₃
AL	< 0.01	< 0.005
Ca	< 0.01	< 0.005
Dy	0.006	-
Eu	-	2
Er	< 0.005	-
Fe	< 0.01	< 0.005
Gd	< 0.005	< 0.01
Но	< 0.005	-
Lu	< 0.005	-
Mg	< 0.01	< 0.005
Nd	< 0.01	< 0.01
Si	0.02	< 0.005
Sm	< 0.005	< 0.01
Tb	< 0.005	< 0.01
Tm	< 0.005	-
Y	-	< 0.01
Yb	0.002	-
Zr	-	< 0.005

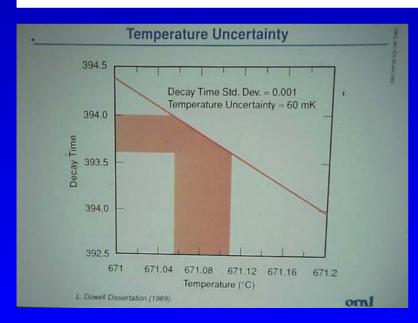
Table III-IV. Impurities in materials used to prepare Y₂O₃:Eu single crystals. The data are percent of composition for each impurity element. The data come from spectrographic analysis and were provided by Commercial Crystal Laboratories, Inc.

Also checked via neutron activation analysis at University of Virginia Reactor Facility.

RESULTS

Temperature (K)	SNR	β	τ (ms)
300	5690:1	2.693138±0.000247	0.930108±0.000140
666	4040:1	2.795084 ± 0.000354	0.896184 ± 0.000157
765	3780:1	2.848691 ± 0.000382	0.879319 ± 0.000158
865	6860:1	1.453592 ± 0.000157	0.688964 ± 0.000224
965	3110:1	0.930440 ± 0.000306	0.270189 ± 0.000187
1064	330:1	1.233660 ± 0.003112	0.040672±0.000178

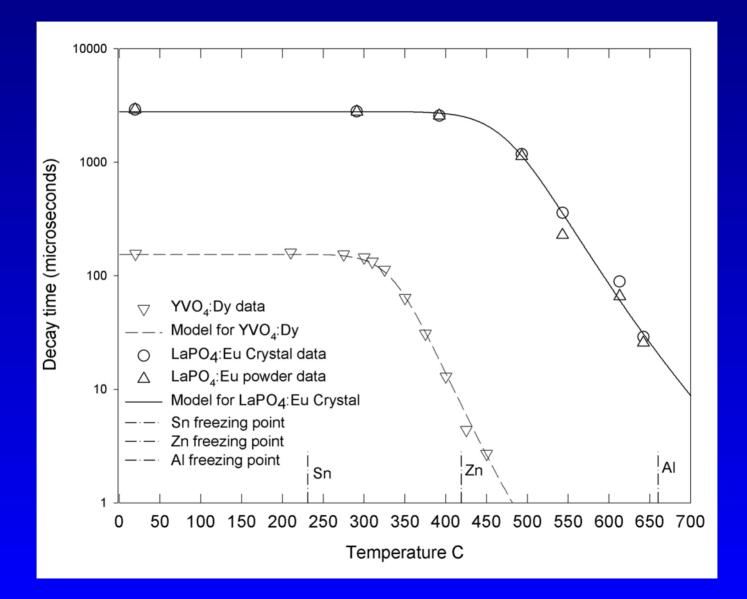
Table IV-IIIb. 1% Eu:Y2O3 611 nm lifetime with excitation near 466 nm.



L. J. Dowell, M.Sc. Thesis, U.Va. May 1987, 299 pp.

L. J. Dowell, Ph.D. Dissertation, U.Va., May 1989, 153 pp.

COMPARISON WITH THE ITS-90



OPEN QUESTIONS UNDER STUDY

- CAN THE UNCERTAINTIES MATCH ITS-90?
- · IS THE DECAY TIME TRULY SINGLE-EXPONENTIAL?
- WHICH PHOSPHOR IS THE BEST?
- · CAN MULTIPLE PHOSPHOR SYSTEMS SPAN THE RANGE FROM 0 K TO 2000+ K?
- WHAT EXCITATION SOURCE IS BEST? (BLUE LEDS?)

THE PHOSPHOR IS THE KEY



Source for SRM photo: <u>http://www.cstl.nist.gov/div836/836.05/thermometry/</u> srms/large_fps.htm

WORK IN PROGRESS

- SUMMARIZE WORK DONE TO DATE IN REVIEW ARTICLE FOR *METROLOGIA*
- CONTINUE DIALOGS WITH COLLEAGUES AT NIST, BIPM AND OTHER STANDARDS LABORATORIES
- CARRY OUT ADDITIONAL LABORATORY WORK ON LONG-TERM STABILITY OF EXPERIMENTAL SYSTEMS
- SEEK POSSIBLE USE WITHIN CONTEXT OF OTHER METROLOGICAL APPLICATIONS

OUR THANKS TO ISA FOR THE OPPORTUNITY TO PRESENT THIS PAPER.

A BRIEF PUBLISHED SUMMARY OF THE WORK DONE TO DATE IS IN THE PROCEEDINGS OF THIS CONFERENCE.